

SLOVENSKI STANDARD oSIST prEN IEC 62037-8:2024

01-junij-2024

Pasivne radiofrekvenčne (RF) in mikrovalovne naprave, meritve intermodulacijskega nivoja - 8. del: Merjenje pasivne intermodulacije, ki jo ustvarjajo objekti, izpostavljeni sevanju RF

Passive RF and microwave devices, intermodulation level measurement - Part 8: Measurement of passive intermodulation generated by objects exposed to RF radiation

Passive HF- und Mikrowellengeräte, Intermodulationspegelmessung - Teil 8: Messung der passiven Intermodulation, verursacht durch Objekte, die HF-Strahlung ausgesetzt sind

Dispositifs RF et à micro-ondes passifs, mesure du niveau d'intermodulation - Partie 8: Mesure de l'intermodulation passive générée par des objets exposés au rayonnement RF

Ta slovenski standard je istoveten z: prEN IEC 62037-8:2024

ICS:

33.120.10 Koaksialni kabli. Valovodi Coaxial cables. Waveguides

33.120.30 Radiofrekvenčni konektorji RF connectors

(RF)

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PROJECT NUMBER:



46/993/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

	IEC 62037-8 ED2				
	DATE OF CIRCULATION	N:	CLOSING DATE FOR VOTING:		
	2024-04-05		2024-06-28		
	SUPERSEDES DOCUM	ENTS:			
	46/951/CD, 46/984	4/CC			
IEC TC 46 : CABLES, WIRES, WAVEGUIDES,	RF CONNECTORS, RF	AND MICROWAVE PASS	SIVE COMPONENTS AND ACCESSORIES		
SECRETARIAT:		SECRETARY:			
United States of America		Mr David Hess			
OF INTEREST TO THE FOLLOWING COMMITTEES:		PROPOSED HORIZONTAL STANDARD:			
SC 46A,SC 46F					
		Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.			
FUNCTIONS CONCERNED:					
☐ EMC ☐ Envire	EMC ENVIRONMENT		QUALITY ASSURANCE SAFETY		
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Attention IEC-CENELEC parallel voting S://standards.iteh.ai					
The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting.					
The CENELEC members are invited to vote through the CENELEC online voting system. OSIST prEN I		EC 62037-8:2024			
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TITLE:					
Passive RF and microwave devices, intermodulation level measurement - Part 8: Measurement of passive intermodulation generated by objects exposed to RF radiation					
PROPOSED STABILITY DATE: 2029					

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PASSIVE RF AND MICROWAVE DEVICES,

INTERMODULATION LEVEL MEASUREMENT -

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Part 8: Measurement of passive intermodulation generated by objects exposed to RF radiation

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- The text of this International Standard is based on the following documents:

Draft	Report on voting
46/902/FDIS	46/911/RVD

- Full information on the voting for its approval can be found in the report on voting indicated in the 81 above table. 82
- The language used for the development of this International Standard is English. 83